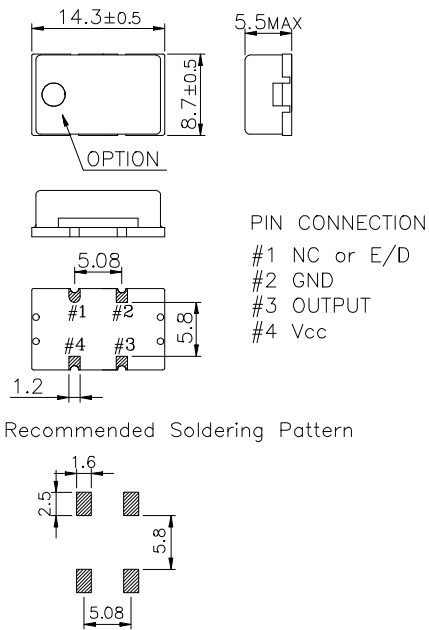
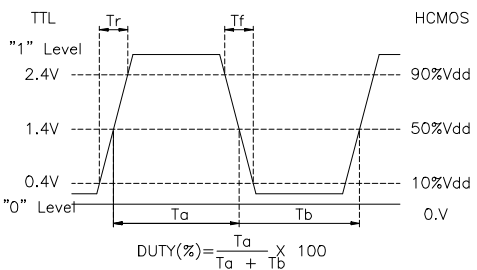
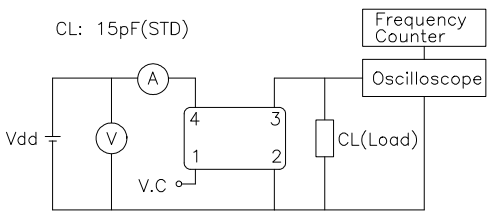


Excequal

Clock Oscillator

CO1494

1KHz ~ 800MHz HCMOS/TTL 15pF or 10TTL

MECHANICAL DIMENSIONS	ELECTRICAL SPECIFICATION																																																	
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